Application/Control No.	Applicant(s)/Patent under Reexamination	
10/743,324	APPS ET AL.	
Examiner	Art Unit	
Tempez Benikiowski	2165	

SEARCHED					
Subclass	Date	Examiner			
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
Inventor Name Search	7/7/2006	TP		
Checked East DB for double patenting	7/7/2006	TP		
USPT, PGPB,JPAB,EPO,DWPI,TDBG	7/7/2006	TP		
Consulted with Neveen Abel-Jalil	7/7/2006	ТР		